

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10518182	ROUTLEY ET AL.
	Examiner	Art Unit
	Mandeville, Jason M	2609

SEARCHED

Class	Subclass	Date	Examiner
345	30, 36, 39, 44-46, 55, 76-83, 204-207, 211-212, 214-215, 690, 697	19 April 2007	Jason Mandeville
345	30, 36, 39, 44-46, 55, 76-83, 204-207, 211-212, 214-215, 690, 697	12/17/2007	Jason Mandeville
345	30, 36, 39, 44-46, 55, 76-83, 204-207, 211-212, 214-215, 690, 697	06 August 2008	Jason Mandeville
345	30, 36, 39, 44-46, 55, 76-83, 204-207, 211-212, 214-215, 690, 697	09 March 2009	Jason Mandeville
345	30, 36, 39, 44-46, 55, 76-83, 204-207, 211-212, 214-215, 690, 697	11/09/2009	Jason Mandeville

SEARCH NOTES

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Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	19 April 2007	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	12/17/2007	Jason Mandeville
Inventor Search	12/17/2007	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	06 August 2008	Jason Mandeville
Inventor Search	06 August 2008	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	09 March 2009	Jason Mandeville
Inventor Search	09 March 2009	Jason Mandeville
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Inventor Search	11/09/2009	Jason Mandeville

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
/J. M. M./ Examiner Art Unit 2629			

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Examiner, Art Unit 2629